## Notice of References Cited Application/Control No. 10/665,591 Examiner Christopher RoDee Applicant(s)/Patent Under Reexamination YAMANOUCHI ET AL. Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2002/0136976	09-2002	Ohmura et al.	430/110.1
	В	US-2004/0043319	03-2004	Horiuchi et al.	430/110.1
	С	US-2003/0027072	02-2003	Horiuchi et al.	430/110.1
	D	US-2003/0215732	11-2003	Uchida et al.	430/111.4
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 08254851 A	10-1996	Japan	ENDO et al.	G03G 09/08
	0					
	Р					
	Q	···				
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	٧						
	w						
	х						

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.